

**Search Notes**

Application/Control No.

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Examiner

Thien D. Tran

Applicant(s)/Patent under  
Reexamination

NAKAHARA ET AL.

Art Unit

2665

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
370	503	10/1/2005	TT
	203	10/1/2005	TT
	210	10/1/2005	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT), 370/203, 206, 207, 210, 503, 516.	10/1/2005	TT